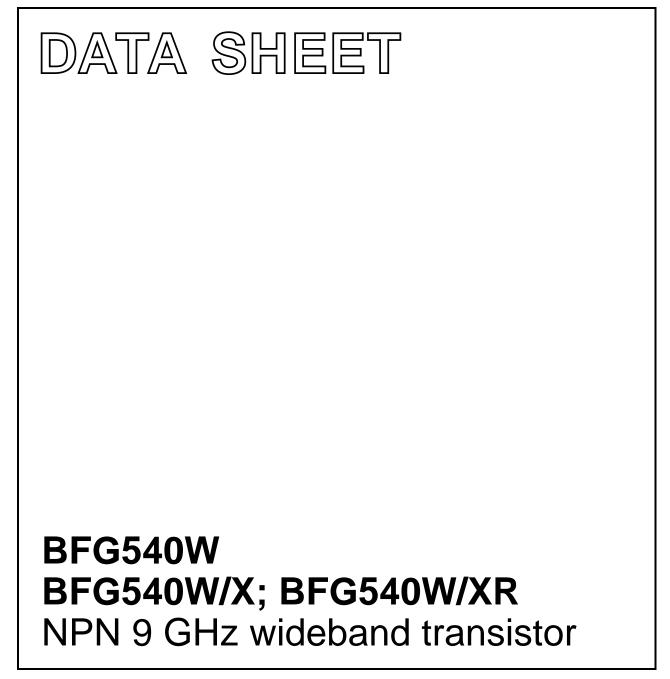
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 1997 Dec 04 2000 May 23



### **FEATURES**

- · High power gain
- Low noise figure
- · High transition frequency · Gold metallization ensures
- excellent reliability.

### APPLICATIONS

RF front end wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT2, CT3, PCN, DECT, etc.), radar detectors, pagers, satellite television tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optic systems.

### DESCRIPTION

NPN silicon planar epitaxial transistors in 4-pin dual-emitter SOT343N and SOT343R plastic packages.

#### MARKING

PINNING

PIN

1

2

3

4

1

2

3

4

1 2

3

4

BFG540W (see Fig.1)

collector

base

emitter

emitter

emitter

emitter

collector

emitter

emitter

base

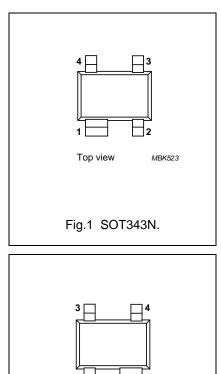
BFG540W/XR (see Fig.2)

base

BFG540W/X (see Fig.1) collector

| TYPE NUMBER | CODE |
|-------------|------|
| BFG540W     | N9   |
| BFG540W/X   | N7   |
| BFG540W/XR  | N8   |

DESCRIPTION



Top view

Fig.2 SOT343R.

MSB842

### QUICK REFERENCE DATA

| SYMBOL                         | PARAMETER                 | CONDITIONS                                                                             | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|---------------------------|----------------------------------------------------------------------------------------|------|------|------|------|
| V <sub>CBO</sub>               | collector-base voltage    | open emitter                                                                           | _    | -    | 20   | V    |
| V <sub>CES</sub>               | collector-emitter voltage | $R_{BE} = 0$                                                                           | _    | -    | 15   | V    |
| Ic                             | collector current (DC)    |                                                                                        | -    | -    | 120  | mA   |
| P <sub>tot</sub>               | total power dissipation   | $T_s \le 85 \ ^{\circ}C$                                                               | -    | -    | 500  | mW   |
| h <sub>FE</sub>                | DC current gain           | I <sub>C</sub> = 40 mA; V <sub>CE</sub> = 8 V                                          | 100  | 120  | 250  |      |
| C <sub>re</sub>                | feedback capacitance      | I <sub>C</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz                                   | -    | 0.5  | -    | pF   |
| f <sub>T</sub>                 | transition frequency      | $I_{C}$ = 40 mA; $V_{CE}$ = 8 V; f = 1 GHz; $T_{amb}$ = 25 °C                          | -    | 9    | -    | GHz  |
| G <sub>UM</sub>                | maximum unilateral        | $I_{C}$ = 40 mA; $V_{CE}$ = 8 V; f = 900 MHz; $T_{amb}$ = 25 °C                        | -    | 16   | -    | dB   |
|                                | power gain                | $I_{C}$ = 40 mA; $V_{CE}$ = 8 V; f = 2 GHz; $T_{amb}$ = 25 °C                          |      | 10   | _    | dB   |
| s <sub>21</sub>   <sup>2</sup> | insertion power gain      | $I_{C}$ = 40 mA; $V_{CE}$ = 8 V; f = 900 MHz; $T_{amb}$ = 25 °C                        | 14   | 15   | -    | dB   |
| F                              | noise figure              | $\Gamma_{s} = \Gamma_{opt}$ ; I <sub>C</sub> = 10 mA; V <sub>CE</sub> = 8 V; f = 2 GHz | -    | 2.1  | -    | dB   |

### BFG540W BFG540W/X; BFG540W/XR

## BFG540W/X; BFG540W/XR

### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL           | PARAMETER                 | CONDITIONS                                  | MIN. | MAX. | UNIT |
|------------------|---------------------------|---------------------------------------------|------|------|------|
| V <sub>CBO</sub> | collector-base voltage    | open emitter                                | -    | 20   | V    |
| V <sub>CES</sub> | collector-emitter voltage | R <sub>BE</sub> = 0                         | -    | 15   | V    |
| V <sub>EBO</sub> | emitter-base voltage      | open collector                              | -    | 2.5  | V    |
| I <sub>C</sub>   | collector current (DC)    |                                             | -    | 120  | mA   |
| P <sub>tot</sub> | total power dissipation   | $T_s \le 85 \ ^\circ C$ ; see Fig.3; note 1 | -    | 500  | mW   |
| T <sub>stg</sub> | storage temperature       |                                             | -65  | +150 | °C   |
| Tj               | junction temperature      |                                             | -    | 175  | °C   |

### Note

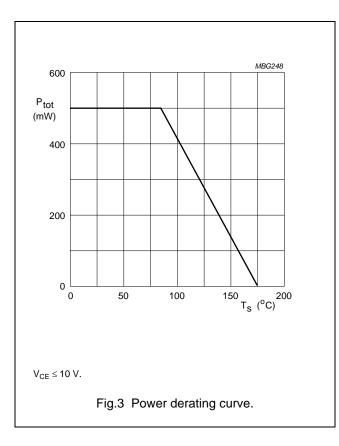
1.  $T_s$  is the temperature at the soldering point of the collector pin.

### THERMAL CHARACTERISTICS

| SYMBOL              | PARAMETER                                           | CONDITIONS                       | VALUE | UNIT |
|---------------------|-----------------------------------------------------|----------------------------------|-------|------|
| R <sub>th j-s</sub> | thermal resistance from junction to soldering point | $T_s \le 85 \ ^\circ C$ ; note 1 | 180   | K/W  |

### Note

1.  $\ensuremath{ T_s}$  is the temperature at the soldering point of the collector pin.



## BFG540W/ BFG540W/X; BFG540W/XR

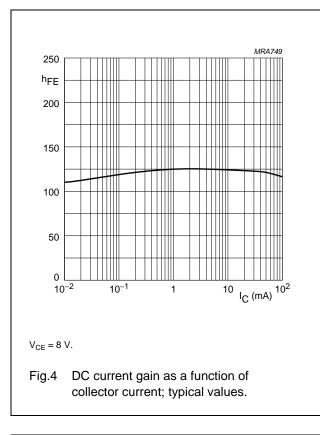
### CHARACTERISTICS

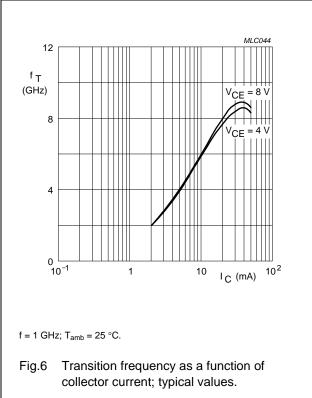
T<sub>j</sub> = 25 °C unless otherwise specified.

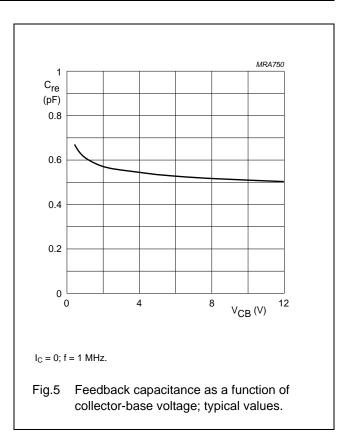
| SYMBOL                         | PARAMETER                               | CONDITIONS                                                                                                 | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|-----------------------------------------|------------------------------------------------------------------------------------------------------------|------|------|------|------|
| V <sub>(BR)CBO</sub>           | collector-base breakdown voltage        | open emitter; $I_C = 10 \ \mu A$ ; $I_E = 0$                                                               | 20   | -    | -    | V    |
| V <sub>(BR)CES</sub>           | collector-emitter breakdown voltage     | R <sub>BE</sub> = 0; I <sub>C</sub> = 40 μA                                                                | 15   | -    | -    | V    |
| V <sub>(BR)EBO</sub>           | emitter-base breakdown<br>voltage       | open collector; $I_E = 100 \ \mu\text{A}$ ; $I_C = 0$                                                      | 2.5  | -    | -    | V    |
| I <sub>CBO</sub>               | collector cut-off current               | open emitter; $V_{CB} = 8 V$ ; $I_E = 0$                                                                   | -    | -    | 50   | nA   |
| h <sub>FE</sub>                | DC current gain                         | I <sub>C</sub> = 40 mA; V <sub>CE</sub> = 8 V                                                              | 100  | 120  | 250  |      |
| f <sub>T</sub>                 | transition frequency                    | $I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V}; f = 1 \text{ GHz};$<br>$T_{amb} = 25 \text{ °C}$               | -    | 9    | -    | GHz  |
| C <sub>c</sub>                 | collector capacitance                   | I <sub>E</sub> = i <sub>e</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz                                      | _    | 0.9  | -    | pF   |
| Ce                             | emitter capacitance                     | $I_{C} = i_{c} = 0; V_{EB} = 0.5 V; f = 1 MHz$                                                             | _    | 2    | -    | pF   |
| C <sub>re</sub>                | feedback capacitance                    | I <sub>C</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz                                                       | _    | 0.5  | -    | pF   |
| G <sub>UM</sub>                | maximum unilateral power gain; note 1   | I <sub>C</sub> = 40 mA; V <sub>CE</sub> = 8 V; f = 900 MHz;<br>T <sub>amb</sub> = 25 °C                    | -    | 16   | _    | dB   |
|                                |                                         | $I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V}; \text{ f} = 2 \text{ GHz};$<br>$T_{amb} = 25 ^{\circ}\text{C}$ | -    | 10   | -    | dB   |
| s <sub>21</sub>   <sup>2</sup> | insertion power gain                    | $I_{C} = 40 \text{ mA}; V_{CE} = 8 \text{ V}; f = 900 \text{ MHz};$<br>$T_{amb} = 25 \text{ °C}$           | 14   | 15   | -    | dB   |
| F                              | noise figure                            | $\Gamma_s = \Gamma_{opt}$ ; I <sub>C</sub> = 10 mA; V <sub>CE</sub> = 8 V;<br>f = 900 MHz                  | -    | 1.3  | 1.8  | dB   |
|                                |                                         | $\Gamma_{s} = \Gamma_{opt}$ ; I <sub>C</sub> = 40 mA; V <sub>CE</sub> = 8 V;<br>f = 900 MHz                | -    | 1.9  | 2.4  | dB   |
|                                |                                         | $\Gamma_s = \Gamma_{opt}$ ; I <sub>C</sub> = 10 mA; V <sub>CE</sub> = 8 V;<br>f = 2 GHz                    | -    | 2.1  | -    | dB   |
| P <sub>L1</sub>                | output power at 1 dB gain compression   | $I_{C}$ = 40 mA; V <sub>CE</sub> = 8 V; f = 900 MHz;<br>R <sub>L</sub> = 50 Ω; T <sub>amb</sub> = 25 °C    | _    | 21   | _    | dBm  |
| ITO                            | third order intercept point             | note 2                                                                                                     | -    | 34   | -    | dBm  |
| Vo                             | output voltage                          | note 3                                                                                                     | -    | 500  | -    | mV   |
| d <sub>2</sub>                 | second order intermodulation distortion | note 4                                                                                                     | -    | -50  | -    | dB   |

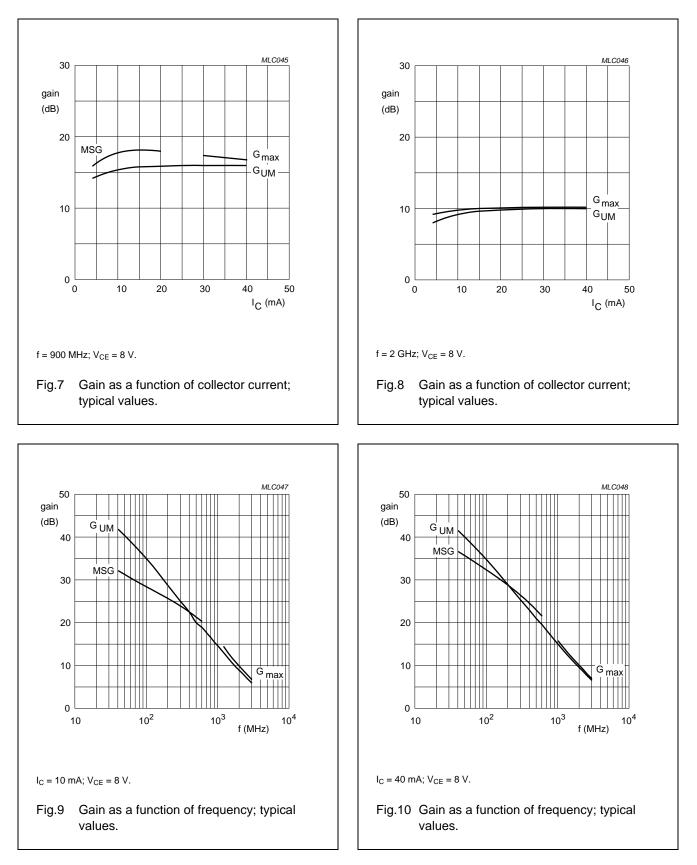
#### Notes

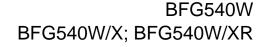
- 1.  $G_{UM}$  is the maximum unilateral power gain, assuming  $s_{12}$  is zero.  $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1-|s_{11}|^2)(1-|s_{22}|^2)} dB$ .
- 2.  $I_C = 40 \text{ mA}$ ;  $V_{CE} = 8 \text{ V}$ ;  $R_L = 50 \Omega$ ;  $T_{amb} = 25 \text{ °C}$ ; a)  $f_p = 900 \text{ MHz}$ ;  $f_q = 902 \text{ MHz}$ ; measured at  $f_{(2p-q)} = 898 \text{ MHz}$  and  $f_{(2q-p)} = 904 \text{ MHz}$ .
- 3.  $d_{im} = -60 \text{ dB} \text{ (DIN45004B)}; V_p = V_o; V_q = V_o 6 \text{ dB}; V_r = V_o 6 \text{ dB}; R_L = 75 \Omega; V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA};$ 
  - a)  $f_p = 795.25$  MHz;  $f_q = 803.25$  MHz;  $f_r = 805.25$  MHz; measured at  $f_{(p + q r)} = 793.25$  MHz.
- 4. I\_C = 40 mA; V\_{CE} = 8 V; V\_o = 275 mV; R\_L = 75  $\Omega;$  T\_amb = 25 °C;
  - a)  $f_p = 250$  MHz;  $f_q = 560$  MHz; measured at  $f_{(p+q)} = 810$  MHz.











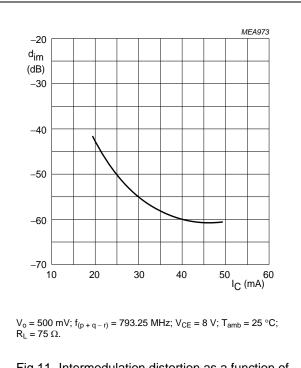
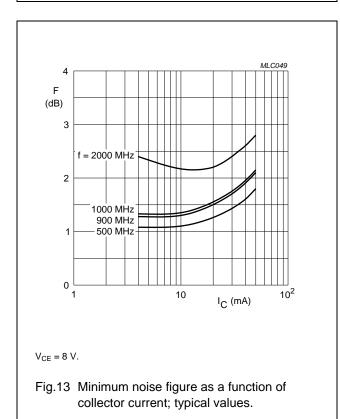


Fig.11 Intermodulation distortion as a function of collector current; typical values.



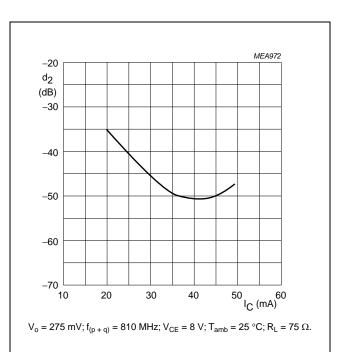
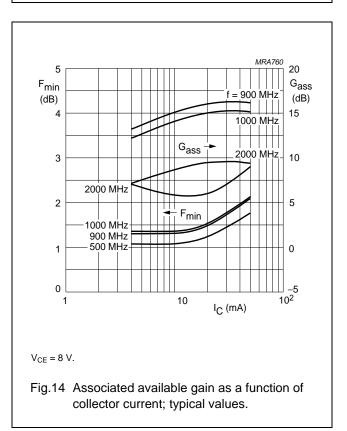
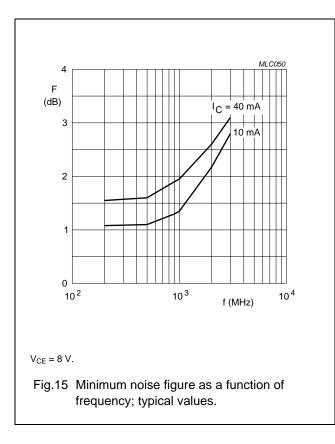
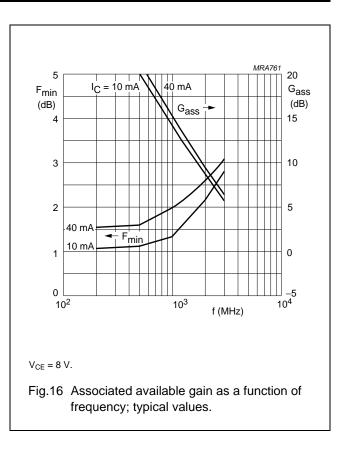
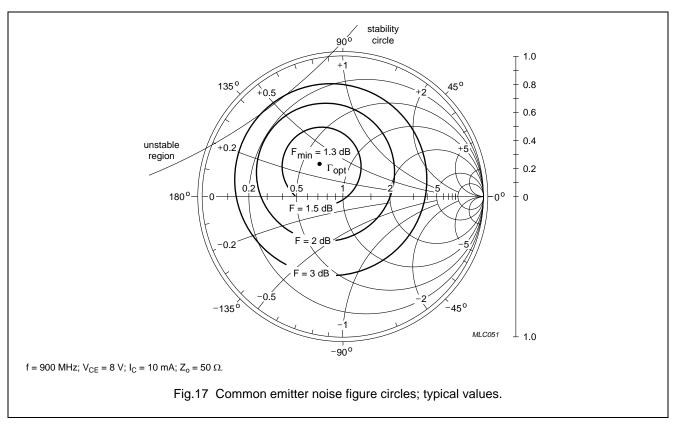


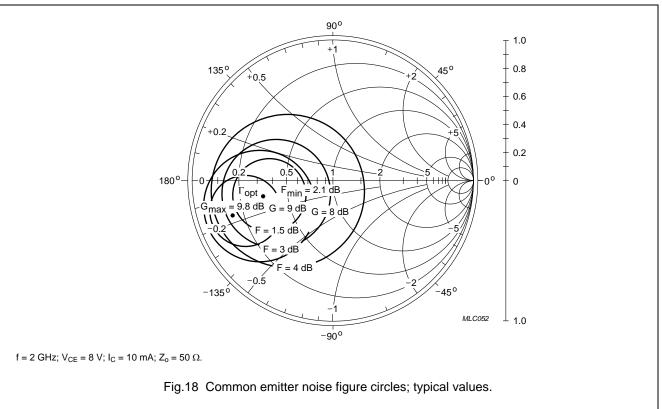
Fig.12 Second order intermodulation distortion as a function of collector current; typical values.

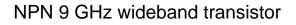




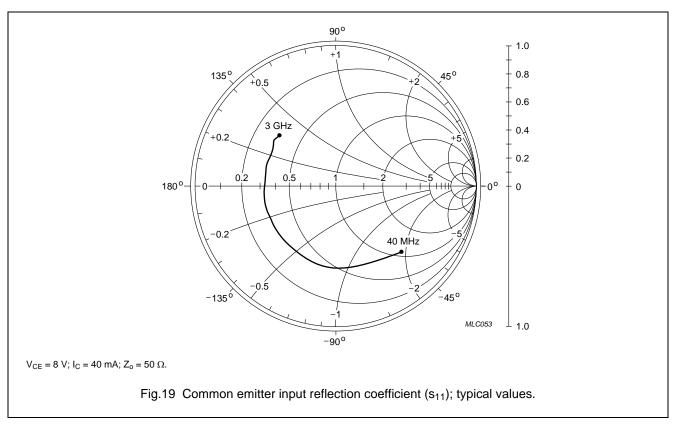


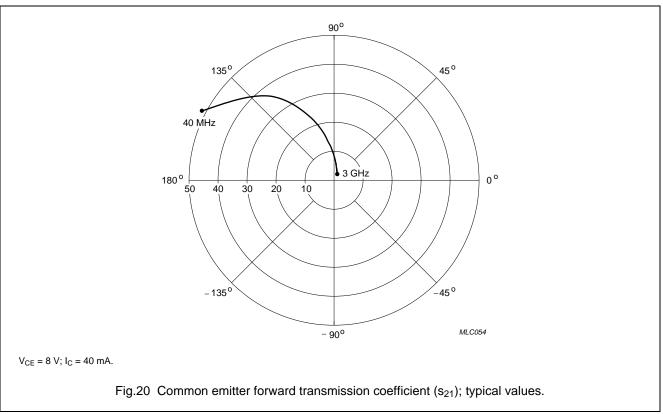


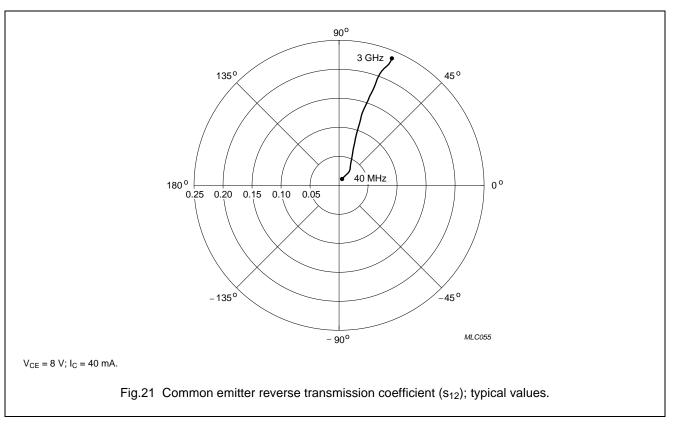


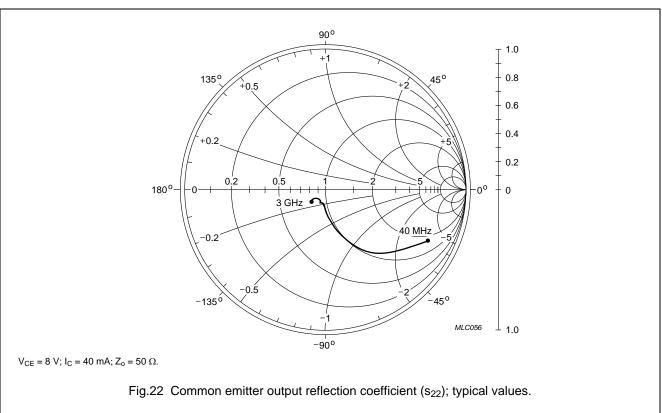


### BFG540W BFG540W/X; BFG540W/XR









BFG540W

## NPN 9 GHz wideband transistor

### SPICE parameters for the BFG540W crystal

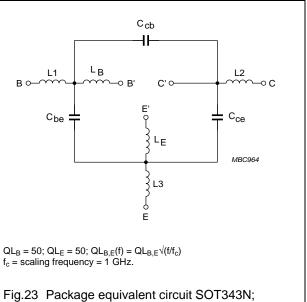
| SEQUENCE No.      | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1                 | IS        | 1.045 | fA   |
| 2                 | BF        | 184.3 | -    |
| 3                 | NF        | 0.981 | -    |
| 4                 | VAF       | 41.69 | V    |
| 5                 | IKF       | 10.00 | А    |
| 6                 | ISE       | 232.4 | fA   |
| 7                 | NE        | 2.028 | -    |
| 8                 | BR        | 43.99 | -    |
| 9                 | NR        | 0.992 | -    |
| 10                | VAR       | 2.097 | V    |
| 11                | IKR       | 166.2 | mA   |
| 12                | ISC       | 129.8 | aA   |
| 13                | NC        | 1.064 | _    |
| 14                | RB        | 5.000 | Ω    |
| 15                | IRB       | 1.000 | μΑ   |
| 16                | RBM       | 5.000 | Ω    |
| 17                | RE        | 353.5 | mΩ   |
| 18                | RC        | 1.340 | Ω    |
| 19 <sup>(1)</sup> | XTB       | 0.000 | -    |
| 20 (1)            | EG        | 1.110 | eV   |
| 21 <sup>(1)</sup> | XTI       | 3.000 | _    |
| 22                | CJE       | 1.978 | pF   |
| 23                | VJE       | 600.0 | mV   |
| 24                | MJE       | 0.332 | _    |
| 25                | TF        | 7.457 | ps   |
| 26                | XTF       | 11.40 | _    |
| 27                | VTF       | 3.158 | V    |
| 28                | ITF       | 156.9 | mA   |
| 29                | PTF       | 0.000 | deg  |
| 30                | CJC       | 793.7 | fF   |
| 31                | VJC       | 185.5 | mV   |
| 32                | MJC       | 0.084 | _    |
| 33                | XCJC      | 0.150 | _    |
| 34                | TR        | 1.598 | ns   |
| 35 <sup>(1)</sup> | CJS       | 0.000 | F    |

#### VALUE UNIT **SEQUENCE No.** PARAMETER 36 (1) VJS 750.0 mV 37 (1) MJS 0.000 \_ 38 FC 0.814 \_

BFG540W/X; BFG540W/XR

### Note

1. These parameters have not been extracted, the default values are shown.



SOT343R.

### List of components (see Fig.23).

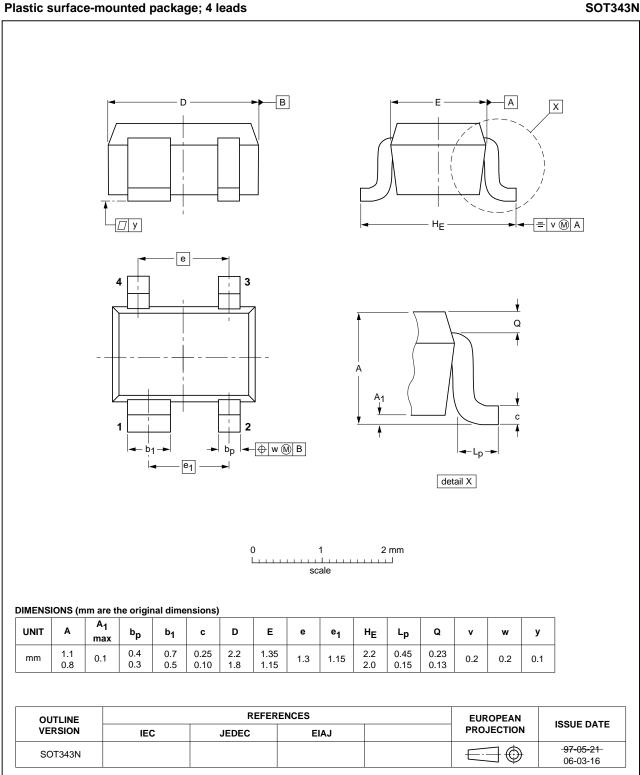
| DESIGNATION     | VALUE | UNIT |
|-----------------|-------|------|
| C <sub>be</sub> | 70    | fF   |
| C <sub>cb</sub> | 50    | fF   |
| C <sub>ce</sub> | 115   | fF   |
| L1              | 0.34  | nH   |
| L2              | 0.10  | nH   |
| L3              | 0.25  | nH   |
| L <sub>B</sub>  | 0.40  | nH   |
| LE              | 0.40  | nH   |

BFG540W

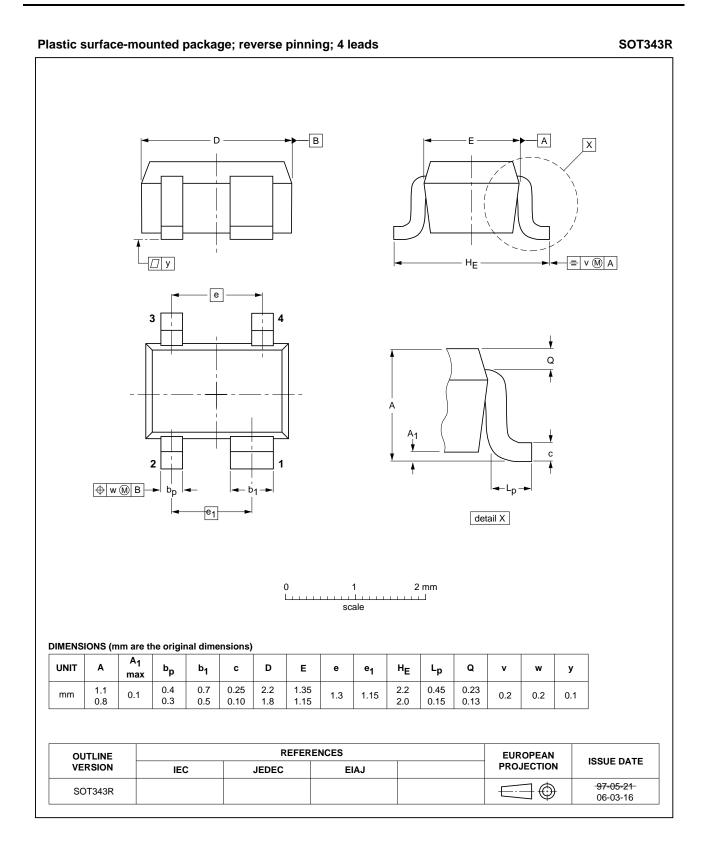
BFG540W/X; BFG540W/XR

## NPN 9 GHz wideband transistor

### **PACKAGE OUTLINES**



SOT343N



## BFG540W/X; BFG540W/XR

### DATA SHEET STATUS

| DOCUMENT<br>STATUS <sup>(1)</sup> | PRODUCT<br>STATUS <sup>(2)</sup> | DEFINITION                                                                            |
|-----------------------------------|----------------------------------|---------------------------------------------------------------------------------------|
| Objective data sheet              | Development                      | This document contains data from the objective specification for product development. |
| Preliminary data sheet            | Qualification                    | This document contains data from the preliminary specification.                       |
| Product data sheet                | Production                       | This document contains the product specification.                                     |

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## BFG540W/X; BFG540W/XR

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### provides High Performance Mixed Signal and Standard Product solutions that leverage its leading RF, Analog, Power Management, Interface, Security and Digital Processing expertise

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#### **Contact information**

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